

EAST - [10686640.wsp:1]

File View Edit Tools Window Help

☐ Drafts
☐ Pending
☒ Active
☐ Failed
☐ Saved
☐ Favorites
☐ Tagged (0)
☐ UDC
☐ Queue
☐ Trash

L1: (7536) high near aspect near ratio and via
 L2: (145) 1 and adhesion near promoter
 L3: (5) 1 and adhesion near promoter and seed near material
 L4: (44) 1 and adhesion near promoter and seed
 L5: (43) 1 and adhesion near promoter and seed and substrate

Search:

Site:

Default operator: OR

1 and adhesion near promoter and seed and substrate

	u	i	Document ID	Issue Date	Pages	Title	Current OR	Current XRef
1	<input type="checkbox"/>	<input type="checkbox"/>	US 20050092621 A1	20050505	23	Composite pad assembly for electrochemical mechanical processing (ECMP)	205/668	
2	<input type="checkbox"/>	<input type="checkbox"/>	US 20050082676 A1	20050421	17	Silicon chip carrier with through-vias using laser assisted chemical vapor deposition of conductor	257/763	
3	<input type="checkbox"/>	<input type="checkbox"/>	US 20050023145 A1	20050203	100	Methods and apparatus for forming multi-layer structures using adhered masks	205/118	205/135
4	<input type="checkbox"/>	<input type="checkbox"/>	US 20040214098 A1	20041028	6	Photoresist formulation for high aspect ratio plating	430/5	
5	<input type="checkbox"/>	<input type="checkbox"/>	US 20040201095 A1	20041014	16	Through-via vertical interconnects, through-via heat sinks and associated fabrication methods	257/700	257/698; 257/E21.597; 257/E23.011
6	<input type="checkbox"/>	<input type="checkbox"/>	US 20040175653 A1	20040909	22	Photosensitive composition and use thereof	430/280.1	430/284.1; 430/285.1; 430/287.1
7	<input type="checkbox"/>	<input type="checkbox"/>	US 20040004001 A1	20040108	32	Method of and apparatus for forming three-dimensional structures integral with semiconductor based carrier	205/118	205/134
8	<input type="checkbox"/>	<input type="checkbox"/>	US 20030190802 A1	20031009	17	Method for forming a plug metal layer	438/672	257/E21.171; 257/E21.564
9	<input type="checkbox"/>	<input type="checkbox"/>	US 20030158731 A1	20030724	7	Photoresist formulation for high aspect ratio plating	430/280.1	430/912; 430/954; 522/170
10	<input type="checkbox"/>	<input type="checkbox"/>	US 20030124787 A1	20030703	17	Method for forming a plug metal layer	438/200	257/E21.171; 257/E21.564
11	<input type="checkbox"/>	<input type="checkbox"/>	US 20030100190 A1	20030529	12	Process for forming a damascene structure	438/710	438/709